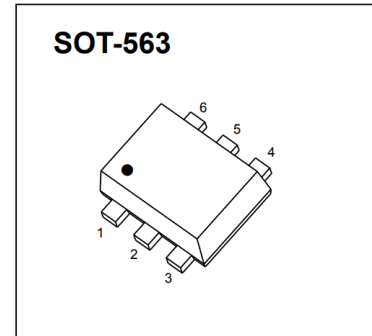


## Plastic-Encapsulate MOSFETS

### N-Channel MOSFET

$V_{(BR)DSS}$	$R_{DS(on)MAX}$	$I_D$
60 V	5Ω @10V	340mA
	5.3Ω @4.5V	



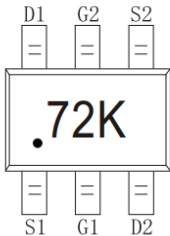
### FEATURE

- ⌘ High density cell design for Low  $R_{DS(on)}$
- ⌘ Voltage controlled small signal switch
- ⌘ Rugged and reliable
- ⌘ High saturation current capability
- ⌘ ESD protected

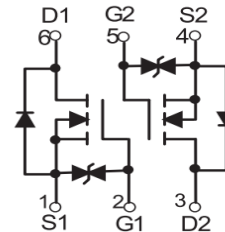
### APPLICATION

- Load Switch for Portable Devices
- DC/DC Converter

### MARKING



### Equivalent Circuit



### MOSFET MAXIMUM RATINGS ( $T_a=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-Source Voltage	60	V
$V_{GS}$	Gate-Source Voltage	±20	V
$I_D$	Continuous Drain Current	340	mA
$I_{DM}$	Pulsed Drain Current(note1)	800	mA
$P_D$	Power Dissipation	0.2	W
$T_j$	Junction Temperature	150	°R
$T_{stg}$	Storage Temperature	-55~+150	°R
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient	625	°R/W

### MOSFET ELECTRICAL CHARACTERISTICS

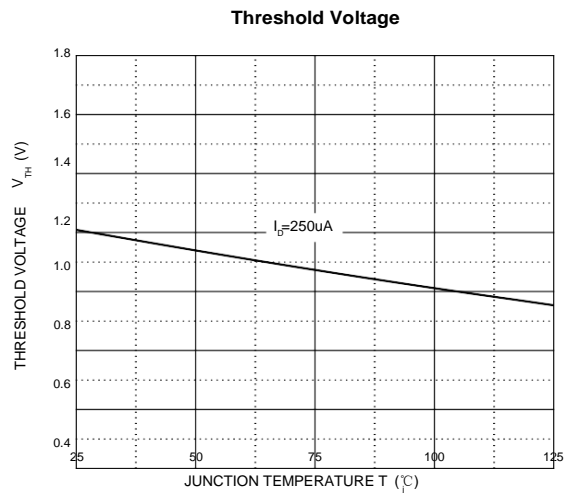
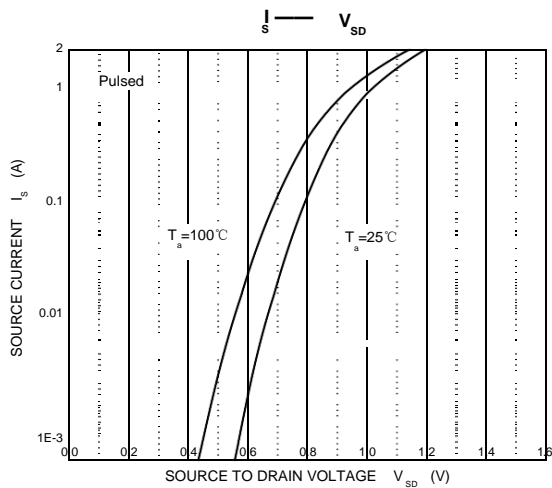
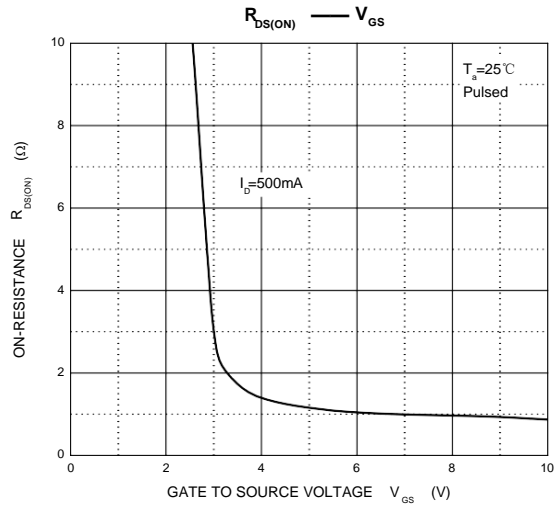
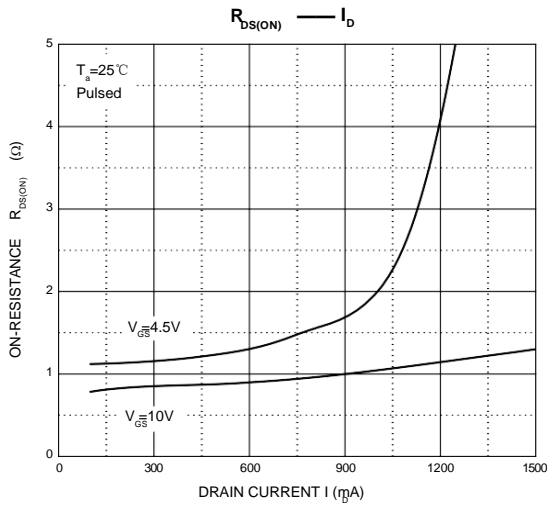
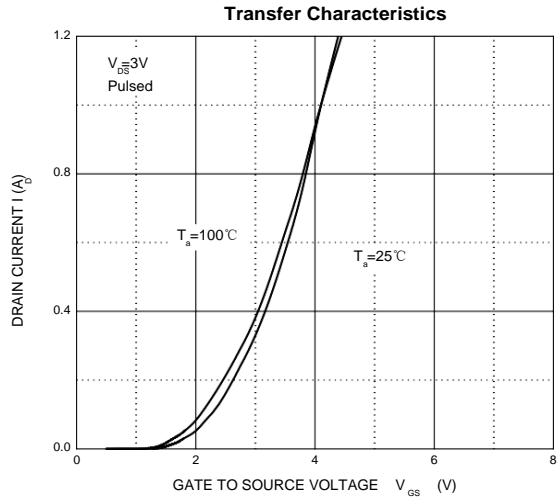
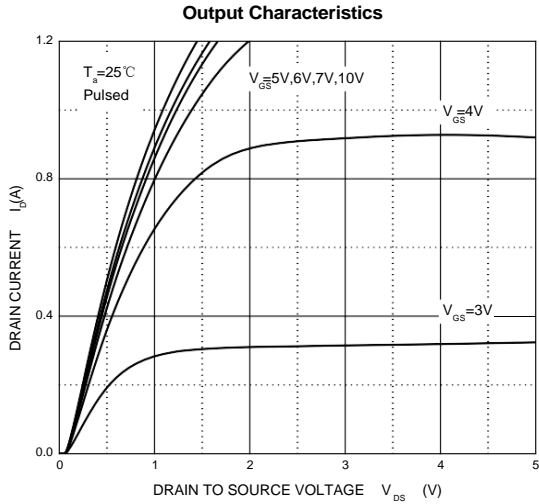
$T_a=25\text{ C}$  unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>STATIC PARAMETERS</b>						
Drain-source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60			V
GateThreshold Voltage (note 2)	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 1mA$	1	1.3	2.5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 48V, V_{GS} = 0V$			1	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 10$	$\mu A$
Drain-Source On-Resistance (note 2)	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 200mA$		2.3	5.3	R
		$V_{GS} = 10V, I_D = 500mA$		1.5	5	R
<b>DYNAMIC PARAMETERS (note 3)</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 10V, V_{GS} = 0V, f = 1MHz$			40	pF
Output Capacitance	$C_{oss}$				30	pF
Reverse Transfer Capacitance	$C_{rss}$				10	pF
<b>SWITCHING PARAMETERS (note 3)</b>						
Turn-on Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DD} = 50V, R_G = 50\Omega$ $R_{GS} = 50\Omega, R_L = 250\Omega$			10	ns
Turn-off Delay Time	$t_{d(off)}$				15	ns
Reverse Recovery Time	$t_{rr}$	$V_{GS} = 0V, I_S = 300mA, V_R = 25V,$ $dI_S/dt = -100A/\mu s$		30		ns
Recovered Charge	$Q_r$	$V_{GS} = 0V, I_S = 300mA, V_R = 25V$ $dI_S/dt = -100A/\mu s$		30		nC
<b>DRAIN-SOURCE DIODE</b>						
Diode Forward Voltage(note 2)	$V_{SD}$	$I_S = 300mA, V_{GS} = 0V$			1.5	V
Continuous Diode Forward Current	$I_S$				0.2	A
Pulsed Diode Forward Current(note1)	$I_{SM}$				0.53	A

**Notes :**

1. Repetitive rating – Pulse width limited by junction temperature.
2. Pulse Test : Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
3. Guaranteed by design, not subject to production testing.

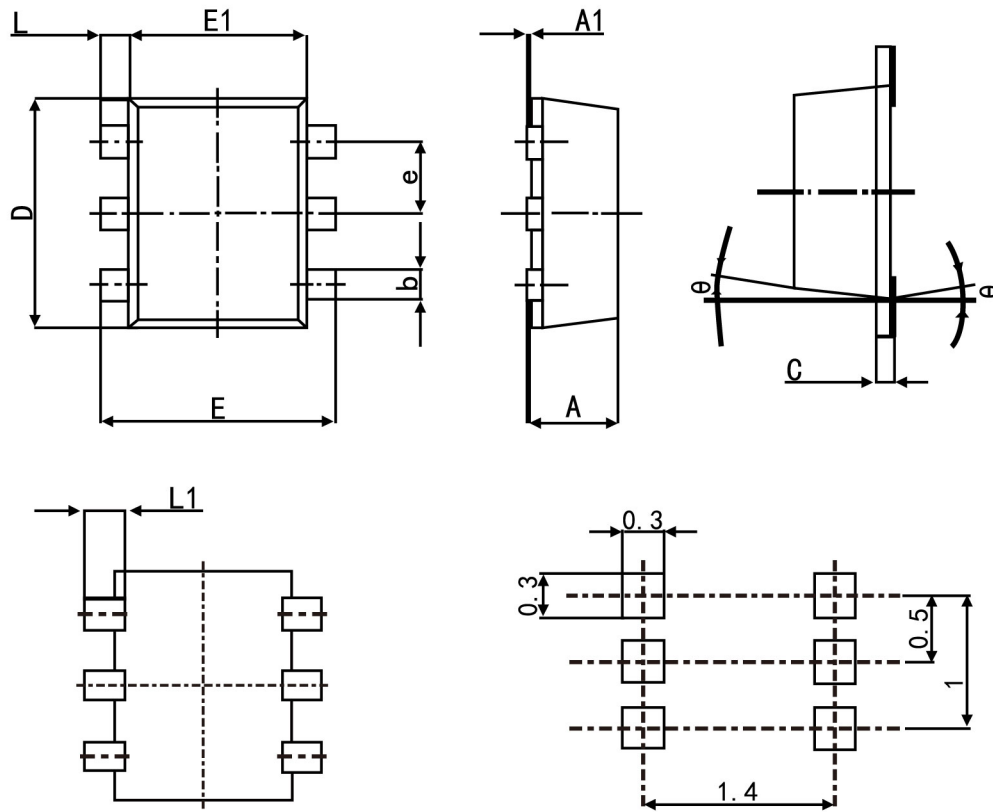
### Typical Characteristics



### PACKAGE OUTLINE

Plastic surface mounted package; 3 leads

SOT-563



Symbol	Dimensions In Millimeters	
	Min.	Max.
A	0.525	0.600
A1	0.000	0.050
e	0.450	0.550
c	0.090	0.160
D	1.500	1.700
b	0.170	0.270
E1	1.100	1.300
E	1.500	1.700
L	0.100	0.300
L1	0.200	0.400
θ	7° REF.	